

Notice of References Cited	Application/Control No. 10/602,629	Applicant(s)/Patent Under Reexamination WATANABE, SHIGEKI	
	Examiner John D. Lee <i>John D. Lee</i>	Art Unit 2874	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,477,300	11-2002	Watanabe et al.	385/42
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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